

Notice of References Cited	Application/Control No. 10/783,940	Applicant(s)/Patent Under Reexamination AN ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,637,151	06-1997	Schulz, Peter	134/2
*	C	US-6,159,860	12-2000	Yang et al.	438/706
*	D	US-6,753,247	06-2004	Okoroanyanwu et al.	438/623
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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